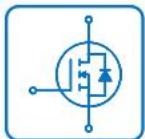




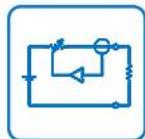
ESD



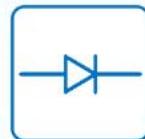
TVS



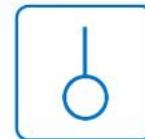
MOS



LDO



Diode



Sensor



DC-DC

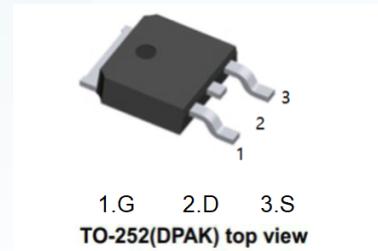
Product Specification

▶ Domestic Part Number	IRLR9343
▶ Overseas Part Number	IRLR9343
▶ Equivalent Part Number	IRLR9343

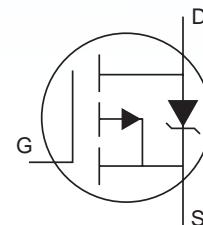


-60V P-Channel MOSFET**Description**

- Advanced Process Technology
- Key Parameters Optimized for Class-D Audio Amplifier Applications
- Low $R_{DS(on)}$ for Improved Efficiency
- Low Q_g and Q_{sw} for Better THD and Improved Efficiency
- Low Q_{rr} for Better THD and Lower EMI
- 175°C Operating Junction Temperature for Ruggedness
- Repetitive Avalanche Capability for Robustness and Reliability
- Multiple Package Options

**Features**

- $V_{DS(V)} = -60V$
- $R_{DS(ON)} < 97m\Omega (V_{GS} = -10V)$
- $R_{DS(ON)} < 130m\Omega (V_{GS} = -4.5V)$

**Absolute Maximum Ratings**

	Parameter	Max.	Units
V_{DS}	Drain-to-Source Voltage	-60	V
V_{GS}	Gate-to-Source Voltage	± 20	
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ -10V$	-20	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	-14	
I_{DM}	Pulsed Drain Current ①	-60	
$P_D @ T_C = 25^\circ C$	Power Dissipation	79	W
$P_D @ T_C = 100^\circ C$	Power Dissipation	39	
	Linear Derating Factor	0.53	W/ $^\circ C$
T_J	Operating Junction and Storage Temperature Range	-40 to + 175	$^\circ C$
T_{STG}	Clamping Pressure ⑥		N

Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ⑤		1.9	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mounted) ⑤⑧		50	$^\circ C/W$
$R_{\theta JA}$	Junction-to-Ambient (free air) ⑤		110	

-60V P-Channel MOSFET**Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)**

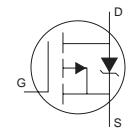
Parameter	Min.	Typ.	Max.	Units	Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	-55		V	$V_{\text{GS}} = 0\text{V}, I_D = -250\mu\text{A}$
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		-52	$\text{mV}/^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = -1\text{mA}$
$R_{\text{DS(on)}}$	Static Drain-to-Source On-Resistance	93	97	$\text{m}\Omega$	$V_{\text{GS}} = -10\text{V}, I_D = -3.4\text{A}$ ③
		100	130		$V_{\text{GS}} = -4.5\text{V}, I_D = -2.7\text{A}$ ③
$V_{\text{GS(th)}}$	Gate Threshold Voltage	-1.1	-2	-3.0	V
$\Delta V_{\text{GS(th)}}/\Delta T_J$	Gate Threshold Voltage Coefficient		-3.7	$\text{mV}/^\circ\text{C}$	
I_{DSS}	Drain-to-Source Leakage Current		-2.0	μA	$V_{\text{DS}} = -55\text{V}, V_{\text{GS}} = 0\text{V}$
			-25		$V_{\text{DS}} = -55\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage		-100	nA	$V_{\text{GS}} = -20\text{V}$
	Gate-to-Source Reverse Leakage		100		$V_{\text{GS}} = 20\text{V}$
g_{fs}	Forward Transconductance	5.3		S	$V_{\text{DS}} = -25\text{V}, I_D = -14\text{A}$
Q_g	Total Gate Charge		31	47	$V_{\text{DS}} = -44\text{V}$ $V_{\text{GS}} = -10\text{V}$ $I_D = -14\text{A}$ See Fig. 6 and 19
Q_{gs}	Gate-to-Source Charge		7.1		
Q_{gd}	Gate-to-Drain Charge		8.5		
Q_{godr}	Gate Charge Overdrive		15		
$t_{\text{d(on)}}$	Turn-On Delay Time		9.5		$V_{\text{DD}} = -28\text{V}, V_{\text{GS}} = -10\text{V}$ ③ $I_D = -14\text{A}$ $R_G = 2.5\Omega$
t_r	Rise Time		24		
$t_{\text{d(off)}}$	Turn-Off Delay Time		21		
t_f	Fall Time		9.5		
C_{iss}	Input Capacitance		660		$V_{\text{GS}} = 0\text{V}$ $V_{\text{DS}} = -50\text{V}$ $f = 1.0\text{MHz}$, See Fig.5 $V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 0\text{V to } -44\text{V}$
C_{oss}	Output Capacitance		160		
C_{rss}	Reverse Transfer Capacitance		72		
C_{osss}	Effective Output Capacitance		280		
L_D	Internal Drain Inductance		4.5		nH Between lead, 6mm (0.25in.) from package and center of die contact ④
L_S	Internal Source Inductance		7.5		

Avalanche Characteristics

Parameter	Typ.	Max.	Units
E_{AS}	Single Pulse Avalanche Energy ②	120	mJ
I_{AR}	Avalanche Current ⑦		A
E_{AR}	Repetitive Avalanche Energy ⑦		mJ

Diode Characteristics

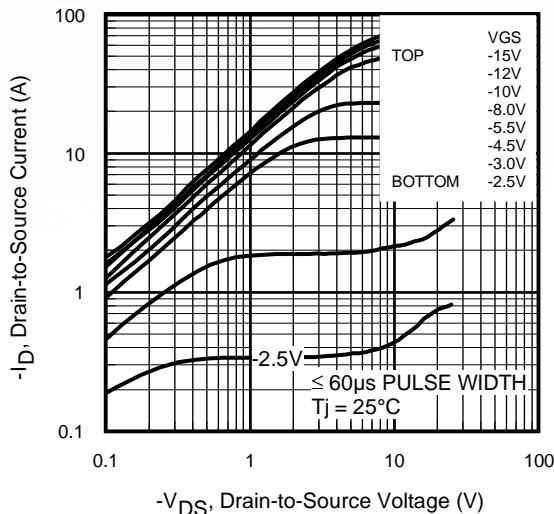
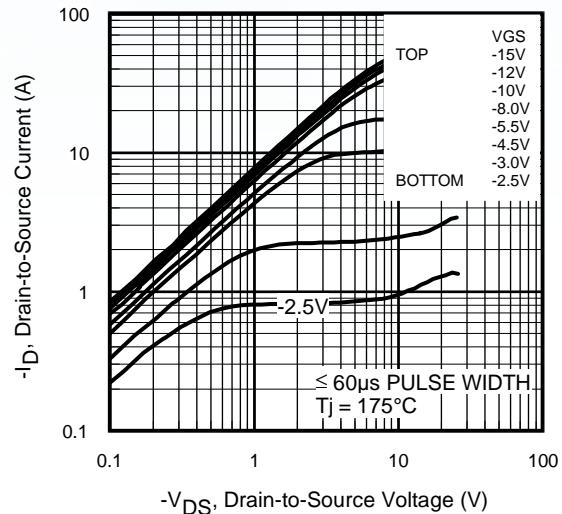
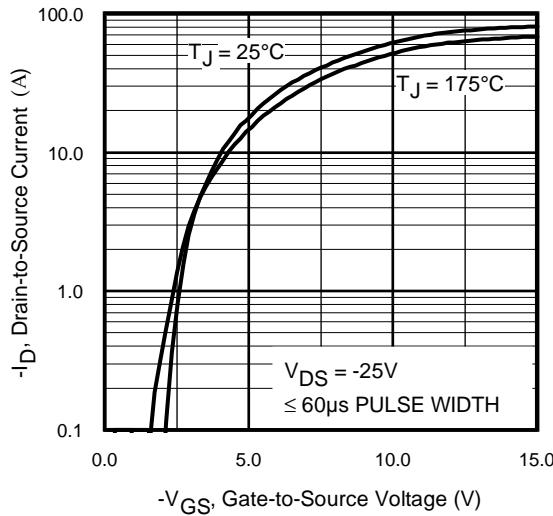
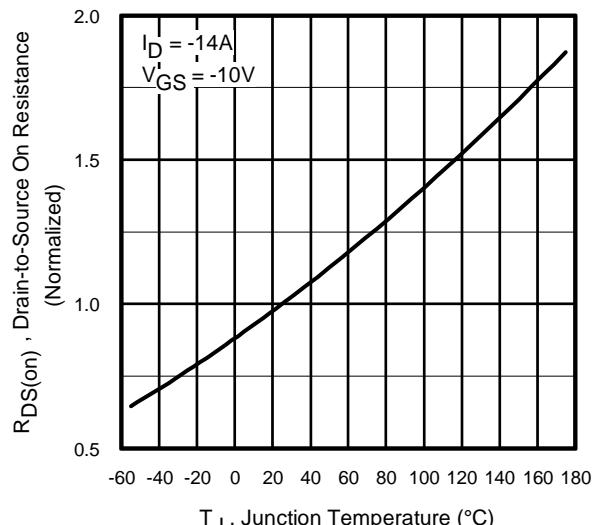
Parameter	Min.	Typ.	Max.	Units	Conditions
$I_s @ T_C = 25^\circ\text{C}$	Continuous Source Current (Body Diode)		-20	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}			-60		
V_{SD}	Diode Forward Voltage		-1.2	V	$T_J = 25^\circ\text{C}, I_s = -14\text{A}, V_{\text{GS}} = 0\text{V}$ ③
t_{rr}	Reverse Recovery Time	57	86	ns	$T_J = 25^\circ\text{C}, I_F = -14\text{A}$ $di/dt = 100\text{A}/\mu\text{s}$ ③
Q_{rr}	Reverse Recovery Charge	120	180	nC	



-60V P-Channel MOSFET**Notes:**

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting $T_J = 25^\circ\text{C}$, $L = 1.24\text{mH}$, $R_G = 25\Omega$, $I_{AS} = -14\text{A}$.
- ③ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.
- ④ This only applies for I-Pak, L_S of D-Pak is measured between lead and center of die contact
- ⑤ R_θ is measured at T_J of approximately 90°C .

- ⑥ Contact factory for mounting information
- ⑦ Limited by $T_{J\max}$. See Figs. 14, 15, 17a, 17b for repetitive avalanche information
- ⑧ When D-Pak mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- ⑨ Refer to D-Pak package for Part Marking, Tape and Reel information.

**Fig 1.** Typical Output Characteristics**Fig 2.** Typical Output Characteristics**Fig 3.** Typical Transfer Characteristics**Fig 4.** Normalized On-Resistance vs. Temperature

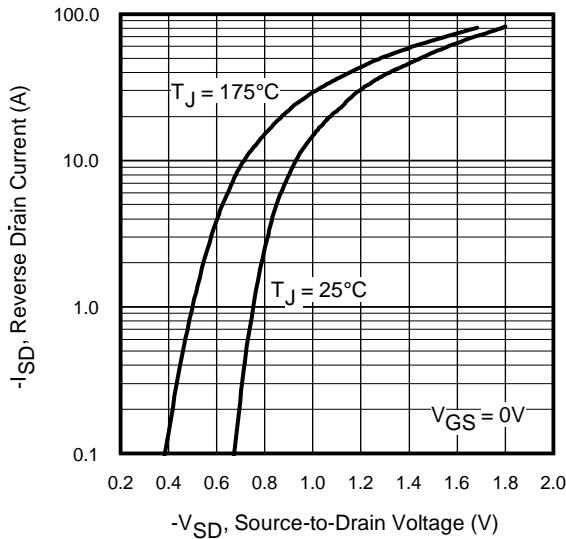
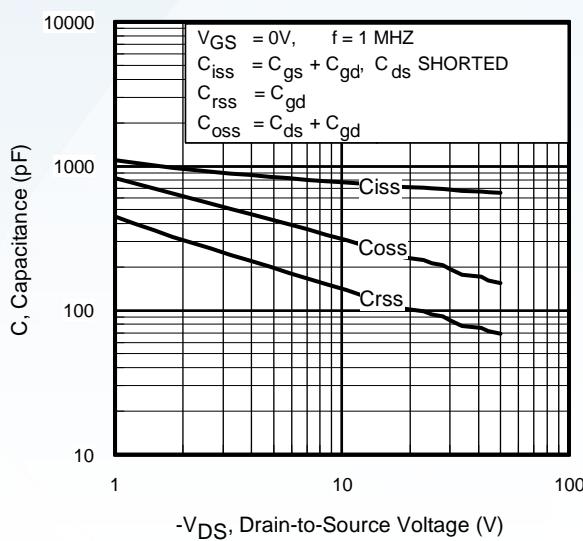


Fig 7. Typical Source-Drain Diode Forward Voltage

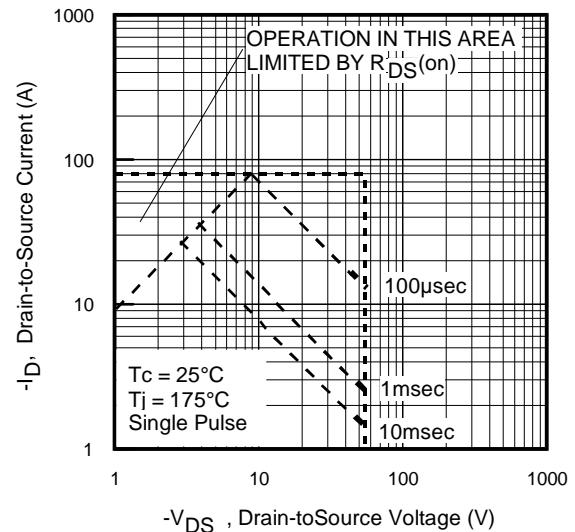
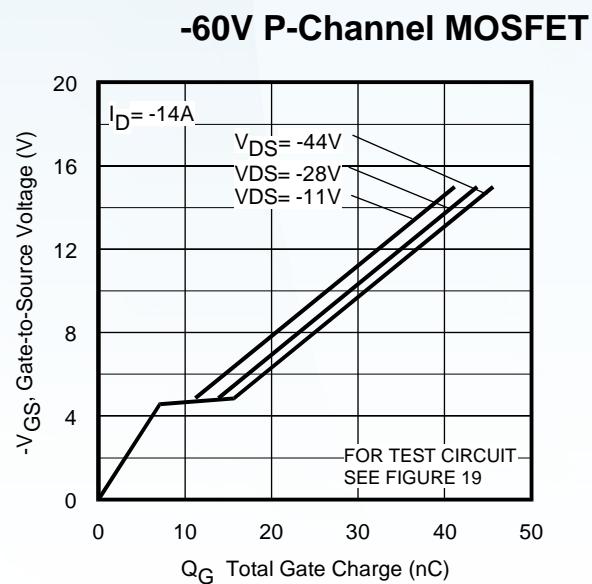


Fig 8. Maximum Safe Operating Area

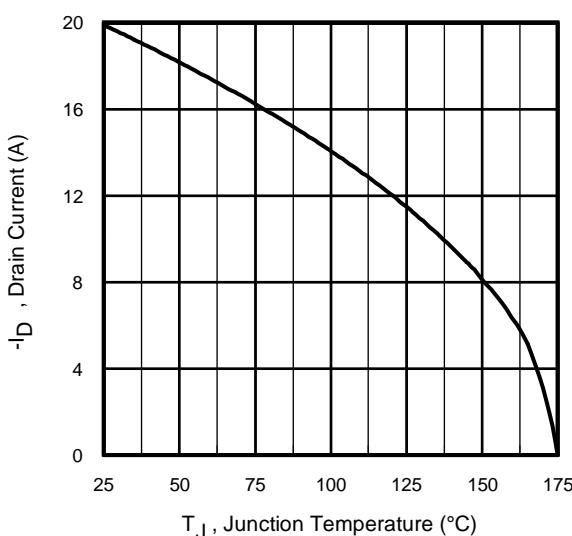


Fig 9. Maximum Drain Current vs. Case Temperature

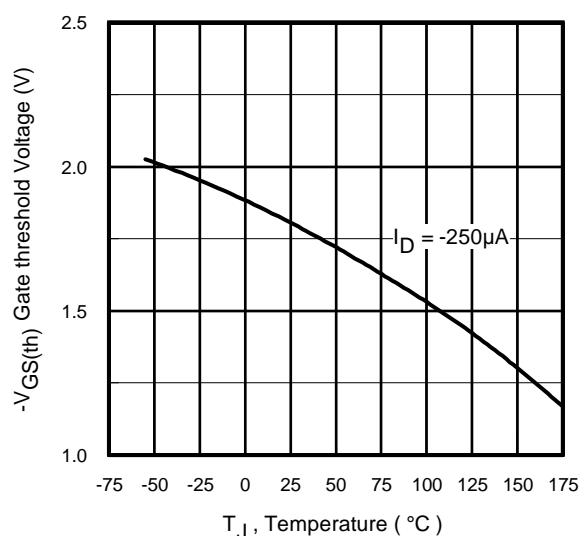
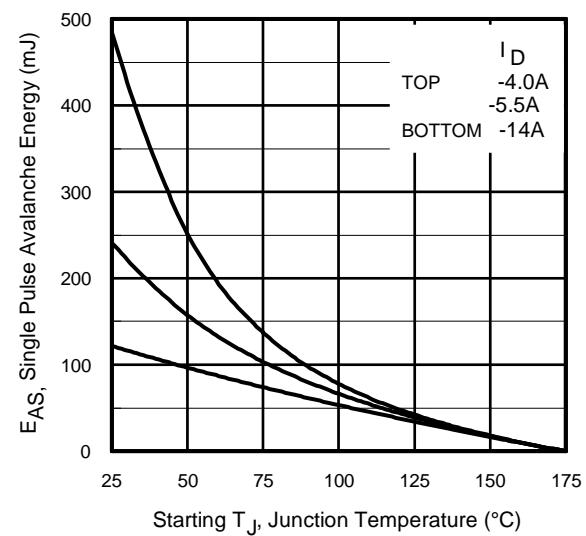
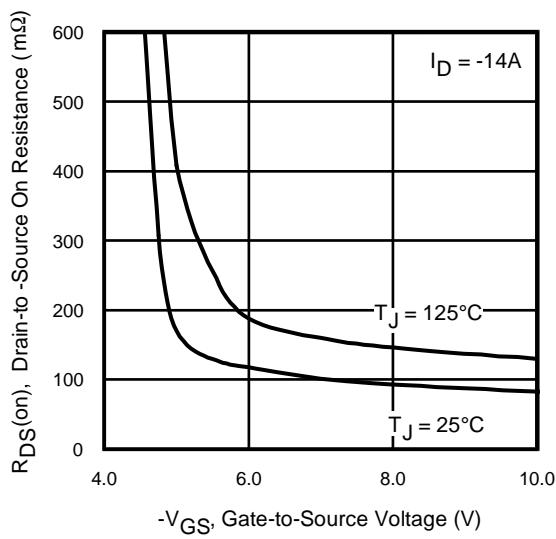
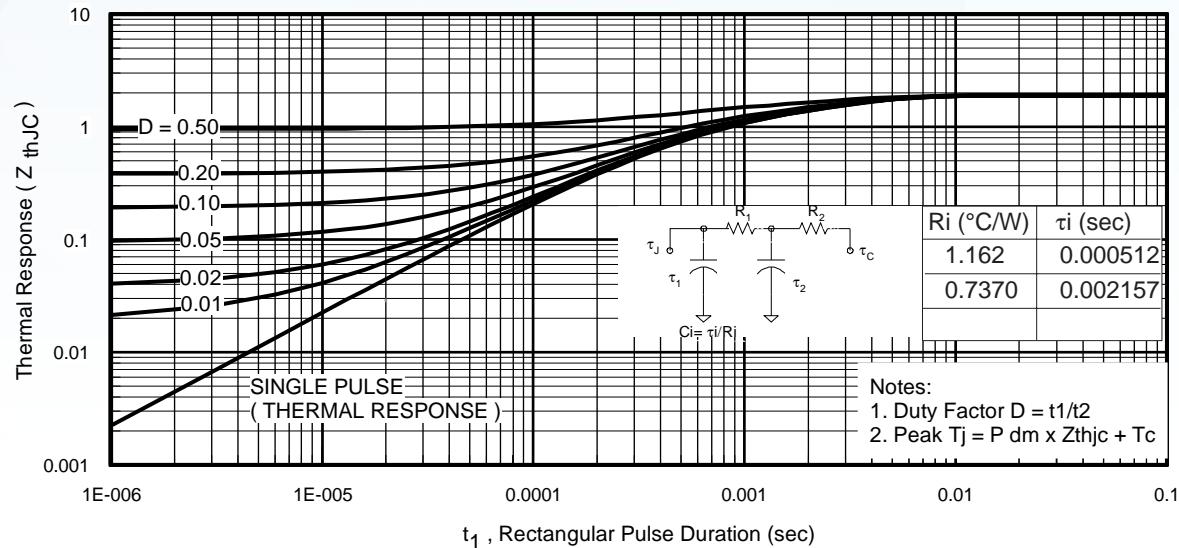


Fig 10. Threshold Voltage vs. Temperature

-60V P-Channel MOSFET


-60V P-Channel MOSFET

Fig 12. On-Resistance Vs. Gate Voltage

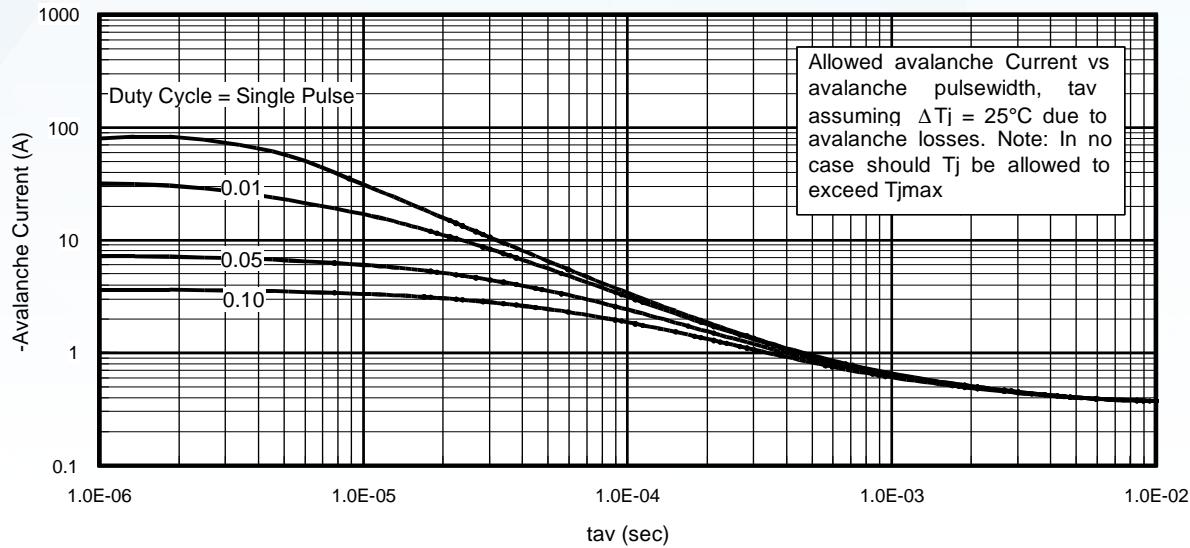


Fig 13. Maximum Avalanche Energy Vs. Drain Current

Allowed avalanche Current vs avalanche pulselwidth, t_{av} assuming $\Delta T_j = 25^\circ\text{C}$ due to avalanche losses. Note: In no case should T_j be allowed to exceed T_{jmax}

Fig 14. Typical Avalanche Current Vs.Pulsewidth

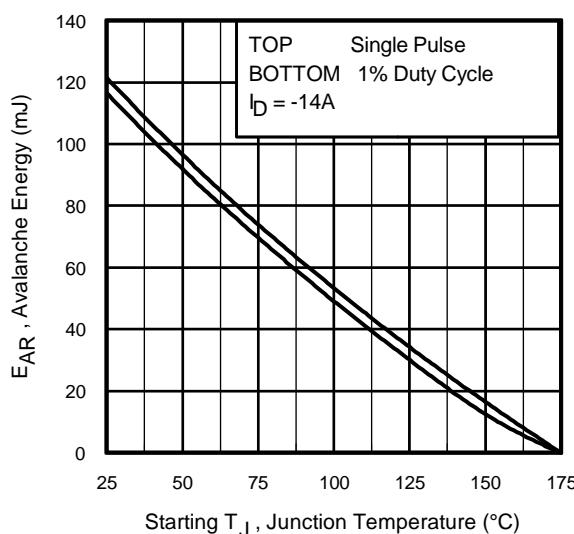


Fig 15. Maximum Avalanche Energy Vs. Temperature

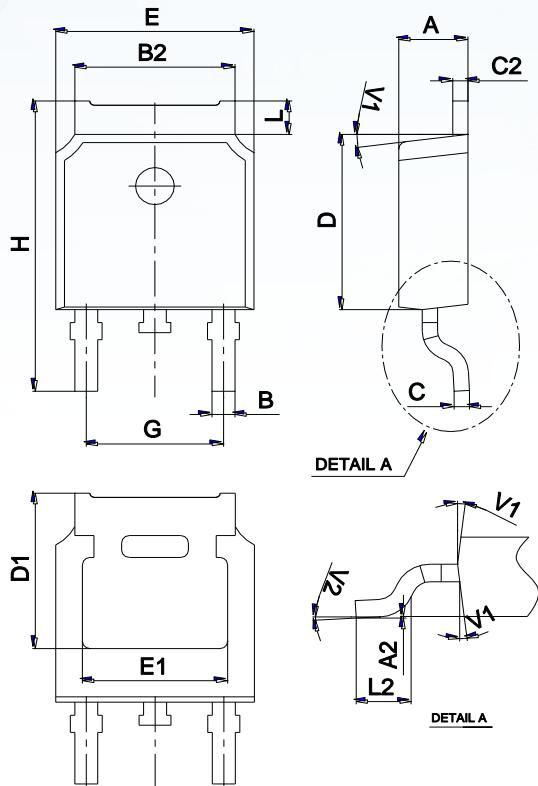
Notes on Repetitive Avalanche Curves , Figures 14, 15:

1. Avalanche failures assumption:
Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
 3. Equation below based on circuit and waveforms shown in Figures 17a, 17b.
 4. $P_D(\text{ave})$ = Average power dissipation per single avalanche pulse.
 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
 6. I_{av} = Allowable avalanche current.
 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 14, 15).
- t_{av} = Average time in avalanche.
 D = Duty cycle in avalanche = $t_{av} \cdot f$
 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see figure 11)

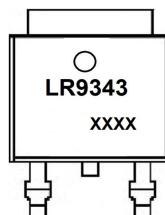
$$P_D(\text{ave}) = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_D(\text{ave}) \cdot t_{av}$$

-60V P-Channel MOSFET
Package Mechanical
Data TO-252


Ref.	Dimensions					
	Millimeters			Inches		
	Min.	Typ.	Max.	Min.	Typ.	Max.
A	2.10		2.50	0.083		0.098
A2	0		0.10	0		0.004
B	0.66		0.86	0.026		0.034
B2	5.18		5.48	0.202		0.216
C	0.40		0.60	0.016		0.024
C2	0.44		0.58	0.017		0.023
D	5.90		6.30	0.232		0.248
D1	5.30REF			0.209REF		
E	6.40		6.80	0.252		0.268
E1	4.63			0.182		
G	4.47		4.67	0.176		0.184
H	9.50		10.70	0.374		0.421
L	1.09		1.21	0.043		0.048
L2	1.35		1.65	0.053		0.065
V1		7°			7°	
V2	0°		6°	0°		6°

Marking

Ordering information

Order code	Package	Baseqty	Deliverymode
IRLR9343	TO-252	2500	Tape and reel

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